

**Notice of References Cited**

Application/Control No.

10/822,309

Applicant(s)/Patent Under  
Reexamination  
LEE ET AL.

Examiner

Venkatesh Haliyur

Art Unit

2619

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0005025	01-2005	Harville et al.	709/241
*	B	US-2004/0128342	07-2004	Maes et al.	709/200
*	C	US-7,290,057	10-2007	Saunders et al.	709/231
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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